



<p><b>Search Notes</b></p> 	<p>Application/Control No.</p> <p>10663645</p>	<p>Applicant(s)/Patent Under Reexamination</p> <p>KASAI ET AL.</p>
	<p>Examiner</p> <p>Xiao, Ke</p>	<p>Art Unit</p> <p>2629</p>

Notes	Date	Examiner
Consulted with Supervising Primary Examiner Sumati Lefkowitz on claim interpretation.	6/6/2006	KX
U.S. Patent and Trademark Office	Part of Paper No.: 20060606	

<p style="text-align: center;"><b>Searched</b></p> 	<p>Application/Control No.</p> <p>10663645</p>	<p>Applicant(s)/Patent Under Reexamination</p> <p>KASAI ET AL.</p>
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Class	SubClass	Date	Examiner
345	78,691-693	6/6/2006	KX

U.S. Patent and Trademark Office	Part of Paper No.: 20060606
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